

<b>Notice of References Cited</b>	Application/Control No. 10/530,829		Applicant(s)/Patent Under Reexamination SCHUBA, MARKO	
	Examiner TRANG DOAN		Art Unit 2431	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,668,876 A	09-1997	Falk et al.	380/271
*	B	US-2002/0103765 A1	08-2002	Ohmori, Mutsuhiro	705/67
*	C	US-2002/0116456 A1	08-2002	Morita, Toru	709/203
*	D	US-2002/0143708 A1	10-2002	Hollander et al.	705/72
*	E	US-2002/0166047 A1	11-2002	Kawamoto, Youji	713/169
*	F	US-2003/0033254 A1	02-2003	Tanaka, Takahiro	705/57
*	G	US-2003/0046541 A1	03-2003	Gerdes et al.	713/168
*	H	US-2003/0093495 A1	05-2003	McNulty et al.	709/217
*	I	US-2004/0172536 A1	09-2004	Malville et al.	713/169
*	J	US-6,928,558 B1	08-2005	Allahwerdi et al.	726/9
*	K	US-7,149,895 B1	12-2006	Asokan et al.	713/159
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.